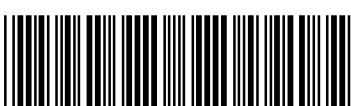


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10737316	HORNBACK ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Liu, Lin	2445

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	216		

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted with SPE Jason Cardone and Primary examiner Winder Patrice L for the restriction requirement.	04/27/2007/	L.L
L1: 709/216.ccls. and (@ad<200031216) reviewed consicely	05/24/2007	L.L
709/216.ccls. not L1, reviewed cursory.	05/24/2007	L.L
Diaglog search attached	05/24/2007	L.L
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	10/30/2007	L.L
Consulted with Jason o the response to the argument.n	10/31/2007	L.L
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	04/08/2008	L.L
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	09/20/2008	L.L
Google patent search attached.	09/20/2008	L.L
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	4/8/2009	L.L
Google patent search attached.	4/8/2009	L.L
Updated Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	11/17/2009	L.L
Updated google patent search attached.	11/17/2009	L.L
Updated Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	5/23/2010	L.L

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>